



**THIS SPEC IS OBSOLETE**

Spec No: 38-05473

Spec Title: CY7C1041DV33, 4-MBIT (256K X 16) STATIC  
RAM

Replaced by: None



## Contents

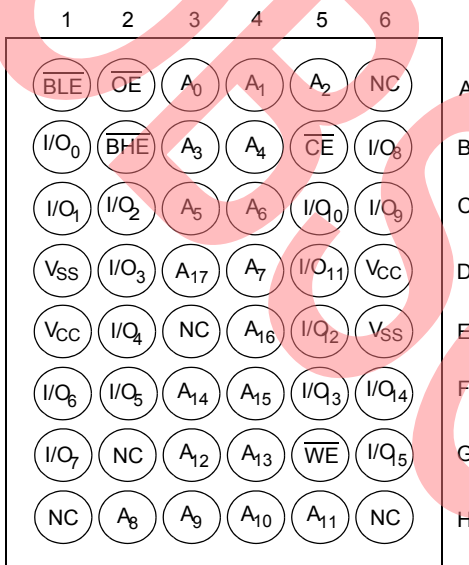
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**Selection Guide**

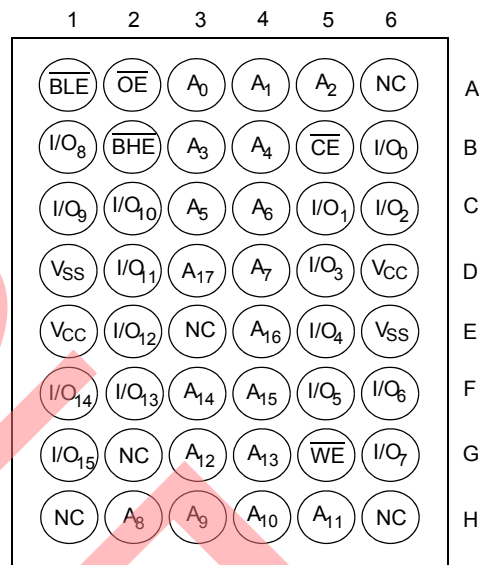
| Description                  | -10 (Industrial) | Unit |
|------------------------------|------------------|------|
| Maximum access time          | 10               | ns   |
| Maximum operating current    | 90               | mA   |
| Maximum CMOS standby current | 10               | mA   |

**Pin Configuration**

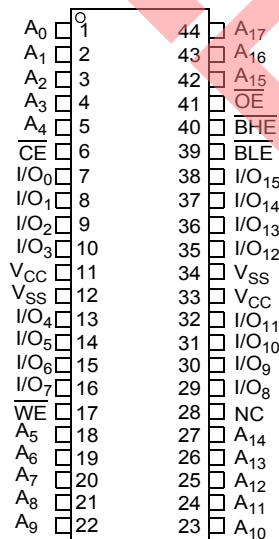
**Figure 1. 48-ball VFBGA (Pinout 1)** [1, 2]



**Figure 2. 48-ball VFBGA (Pinout 2)** [1, 2]



**Figure 3. 44-pin SOJ/TSOP II pinout**



**Notes**

1. NC pins are not connected on the die.
2. Pinout 1 is compliant with CY7C1041CV33 and pinout 2 is JEDEC compliant. The difference between the two is that the higher and lower byte I/Os (I/O<sub>[7:0]</sub> and I/O<sub>[15:8]</sub> balls) are swapped.

**Maximum Ratings**

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

- Storage temperature ..... -65 °C to +150 °C
- Ambient temperature with power applied ..... -55 °C to +125 °C
- Supply voltage on V<sub>CC</sub> relative to GND [3] ... -0.3 V to +4.6 V
- DC voltage applied to outputs in high Z State [3] ..... -0.3 V to V<sub>CC</sub> + 0.3 V

- DC input voltage [3] ..... -0.3 V to V<sub>CC</sub> + 0.3 V
- Current into outputs (LOW) ..... 20 mA
- Static discharge voltage (MIL-STD-883, method 3015) ..... > 2001 V
- Latch up current ..... > 200 mA

**Operating Range**

| Range      | Ambient Temperature | V <sub>CC</sub> | Speed |
|------------|---------------------|-----------------|-------|
| Industrial | -40 °C to +85 °C    | 3.3 V ± 0.3 V   | 10 ns |

**DC Electrical Characteristics**

Over the Operating Range

| Parameter                      | Description                                   | Test Conditions  | -10 (Industrial) |                       | Unit |    |
|--------------------------------|---|--|------------------|-----------------------|------|----|
|                                |   |  | Min              | Max                   |      |    |
| V <sub>OH</sub>                | Output HIGH voltage                           | V <sub>CC</sub> = Min, I <sub>OH</sub> = -4.0 mA   | 2.4              | -                     | V    |    |
| V <sub>OL</sub>                | Output LOW voltage                            | V <sub>CC</sub> = Min, I <sub>OL</sub> = 8.0 mA  | -                | 0.4                   | V    |    |
| V <sub>IH</sub> <sup>[3]</sup> | Input HIGH voltage                            |  | 2.0              | V <sub>CC</sub> + 0.3 | V    |    |
| V <sub>IL</sub> <sup>[3]</sup> | Input LOW voltage                             |  | -0.3             | 0.8                   | V    |    |
| I <sub>IX</sub>                | Input leakage current                         | GND ≤ V <sub>I</sub> ≤ V <sub>CC</sub>   | -1               | +1                    | μA   |    |
| I <sub>OZ</sub>                | Output leakage current                        | GND ≤ V <sub>OUT</sub> ≤ V <sub>CC</sub> , output disabled   | -1               | +1                    | μA   |    |
| I <sub>CC</sub>                | V <sub>CC</sub> operating supply current      | V <sub>CC</sub> = Max, f = f <sub>MAX</sub> = 1/t <sub>RC</sub>  | 100 MHz          | -                     | 90   | mA |
|                                |   |  | 83 MHz           | -                     | 80   | mA |
|                                |   |  | 66 MHz           | -                     | 70   | mA |
|                                |   |  | 40 MHz           | -                     | 60   | mA |
| I <sub>SB1</sub>               | Automatic CE power-down current – TTL inputs  | Max V <sub>CC</sub> , CE ≥ V <sub>IH</sub> , V <sub>IN</sub> ≥ V <sub>IH</sub> or V <sub>IN</sub> ≤ V <sub>IL</sub> , f = f <sub>MAX</sub> | -                | 20                    | mA   |    |
| I <sub>SB2</sub>               | Automatic CE power-down current – CMOS inputs | Max V <sub>CC</sub> , CE ≥ V <sub>CC</sub> - 0.3 V, V <sub>IN</sub> ≥ V <sub>CC</sub> - 0.3 V or V <sub>IN</sub> ≤ 0.3 V, f = 0            | -                | 10                    | mA   |    |

**Note**

3. Minimum voltage is -2.0 V and V<sub>IH</sub>(max) = V<sub>CC</sub> + 2 V for pulse durations of less than 20 ns.

### Capacitance

| Parameter <sup>[4]</sup> | Description       | Test Conditions  | Max | Unit |
|--------------------------|-------------------|--|-----|------|
| C <sub>IN</sub>          | Input capacitance | T <sub>A</sub> = 25 °C, f = 1 MHz, V <sub>CC</sub> = 3.3 V | 8   | pF   |
| C <sub>OUT</sub>         | I/O capacitance   |  | 8   | pF   |

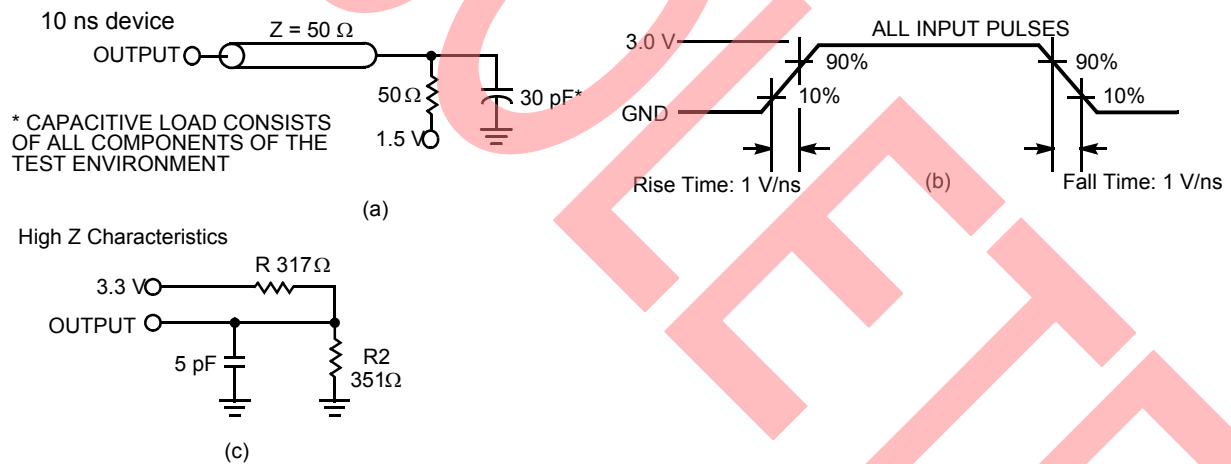
### Thermal Resistance

| Parameter <sup>[4]</sup> | Description                              | Test Conditions   | 48-ball FBGA Package | 44-pin SOJ Package | 44-pin TSOP II Package | Unit |
|--------------------------|--|---|----------------------|--------------------|------------------------|------|
| Θ <sub>JA</sub>          | Thermal resistance (junction to ambient) | Still Air, soldered on a 3 × 4.5 inch, four layer printed circuit board | 27.89                | 57.91              | 50.66                  | °C/W |
| Θ <sub>JC</sub>          | Thermal resistance (junction to case)    |   | 14.74                | 36.73              | 17.17                  | °C/W |

### AC Test Loads and Waveforms

The AC test loads and waveform diagram follows.

Figure 4. AC Test Loads and Waveforms <sup>[5]</sup>



**Notes**

- 4. Tested initially and after any design or process changes that may affect these parameters.
- 5. AC characteristics (except high Z) are tested using the load conditions shown in Figure 4 (a). High Z characteristics are tested for all speeds using the test load shown in Figure 4 (c).

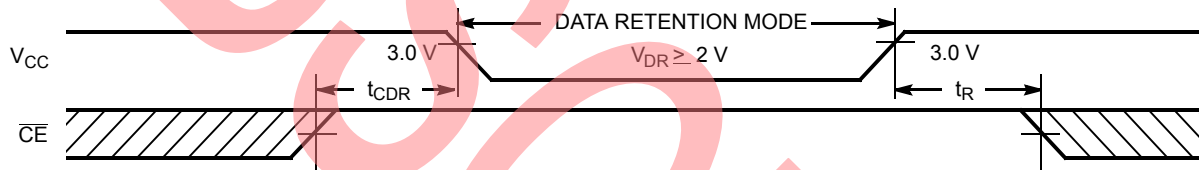
### Data Retention Characteristics

Over the Operating Range

| Parameter       | Description                          | Conditions <sup>[6]</sup>  | Min      | Max | Unit |
|-----------------|--------------------------------------|--|----------|-----|------|
| $V_{DR}$        | $V_{CC}$ for data retention          |  | 2.0      | –   | V    |
| $I_{CCDR}$      | Data retention current               | $V_{CC} = V_{DR} = 2.0\text{ V}$ , $\overline{CE} \geq V_{CC} - 0.3\text{ V}$ ,<br>$V_{IN} \geq V_{CC} - 0.3\text{ V}$ or $V_{IN} \leq 0.3\text{ V}$ | –        | 10  | mA   |
| $t_{CDR}^{[7]}$ | Chip deselect to data retention time |  | 0        | –   | ns   |
| $t_R^{[8]}$     | Operation recovery time              |  | $t_{RC}$ | –   | ns   |

### Data Retention Waveform

Figure 5. Data Retention Waveform



**Notes**

- 6. No input may exceed  $V_{CC} + 0.3\text{ V}$ .
- 7. Tested initially and after any design or process changes that may affect these parameters.
- 8. Full device operation requires linear  $V_{CC}$  ramp from  $V_{DR}$  to  $V_{CC(min.)} \geq 50\ \mu\text{s}$  or stable at  $V_{CC(min.)} \geq 50\ \mu\text{s}$ .

## AC Switching Characteristics

Over the Operating Range

| Parameter <sup>[9]</sup>               | Description  | -10 (Industrial) |     | Unit    |
|--|--|------------------|-----|---------|
|  |  | Min              | Max |         |
| <b>Read Cycle</b>                      |  |                  |     |         |
| $t_{power}^{[10]}$                     | $V_{CC}$ (Typical) to the first access             | 100              | –   | $\mu$ s |
| $t_{RC}$                               | Read cycle time                                    | 10               | –   | ns      |
| $t_{AA}$                               | Address to data valid                              | –                | 10  | ns      |
| $t_{OHA}$                              | Data hold from address change                      | 3                | –   | ns      |
| $t_{ACE}$                              | $\overline{CE}$ LOW to data valid                  | –                | 10  | ns      |
| $t_{DOE}$                              | $\overline{OE}$ LOW to data valid                  | –                | 5   | ns      |
| $t_{LZOE}$                             | $\overline{OE}$ LOW to low Z <sup>[11]</sup>       | 0                | –   | ns      |
| $t_{HZOE}$                             | $\overline{OE}$ HIGH to high Z <sup>[11, 12]</sup> | –                | 5   | ns      |
| $t_{LZCE}$                             | $\overline{CE}$ LOW to low Z <sup>[11]</sup>       | 3                | –   | ns      |
| $t_{HZCE}$                             | $\overline{CE}$ HIGH to high Z <sup>[11, 12]</sup> | –                | 5   | ns      |
| $t_{PU}$                               | $\overline{CE}$ LOW to power-up                    | 0                | –   | ns      |
| $t_{PD}$                               | $\overline{CE}$ HIGH to power-down                 | –                | 10  | ns      |
| $t_{DBE}$                              | Byte enable to data valid                          | –                | 5   | ns      |
| $t_{LZBE}$                             | Byte enable to low Z                               | 0                | –   | ns      |
| $t_{HZBE}$                             | Byte disable to high Z                             | –                | 6   | ns      |
| <b>Write Cycle</b> <sup>[13, 14]</sup> |  |                  |     |         |
| $t_{WC}$                               | Write cycle time                                   | 10               | –   | ns      |
| $t_{SCE}$                              | $\overline{CE}$ LOW to write end                   | 7                | –   | ns      |
| $t_{AW}$                               | Address setup to write end                         | 7                | –   | ns      |
| $t_{HA}$                               | Address hold from write end                        | 0                | –   | ns      |
| $t_{SA}$                               | Address setup to write start                       | 0                | –   | ns      |
| $t_{PWE}$                              | $\overline{WE}$ pulse width                        | 7                | –   | ns      |
| $t_{SD}$                               | Data setup to write end                            | 5                | –   | ns      |
| $t_{HD}$                               | Data hold from write end                           | 0                | –   | ns      |
| $t_{LZWE}$                             | $\overline{WE}$ HIGH to low Z <sup>[11]</sup>      | 3                | –   | ns      |
| $t_{HZWE}$                             | $\overline{WE}$ LOW to high Z <sup>[11, 12]</sup>  | –                | 5   | ns      |
| $t_{BW}$                               | Byte enable to end of write                        | 7                | –   | ns      |

### Notes

9. Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, input pulse levels of 0 to 3.0 V, and output loading of the specified  $I_{OL}/I_{OH}$  and 30-pF load capacitance.
10.  $t_{POWER}$  gives the minimum amount of time that the power supply should be at typical  $V_{CC}$  values until the first memory access is performed.
11. At any given temperature and voltage condition,  $t_{HZCE}$  is less than  $t_{LZCE}$ ,  $t_{HZOE}$  is less than  $t_{LZOE}$ ,  $t_{HZBE}$  is less than  $t_{LZBE}$ , and  $t_{HZWE}$  is less than  $t_{LZWE}$  for any given device.
12.  $t_{HZOE}$ ,  $t_{HZCE}$ ,  $t_{HZBE}$ , and  $t_{HZWE}$  are specified with a load capacitance of 5 pF as in part (c) of Figure 4. Transition is measured when the outputs enter a high impedance state.
13. The internal write time of the memory is defined by the overlap of  $\overline{CE}$  LOW and  $BHE$  or  $BLE$ , and  $\overline{WE}$  LOW. All signals must be in valid states to initiate a Write, but any one signal can go inactive to terminate the write.
14. The minimum write cycle time for Write Cycle No. 4 ( $\overline{WE}$  controlled,  $\overline{OE}$  LOW) is the sum of  $t_{HZWE}$  and  $t_{SD}$ .



Switching Waveforms

Figure 6. Read Cycle No. 1 [15, 16]

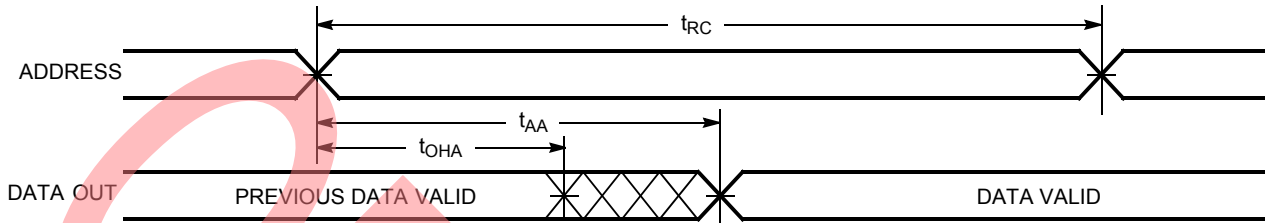
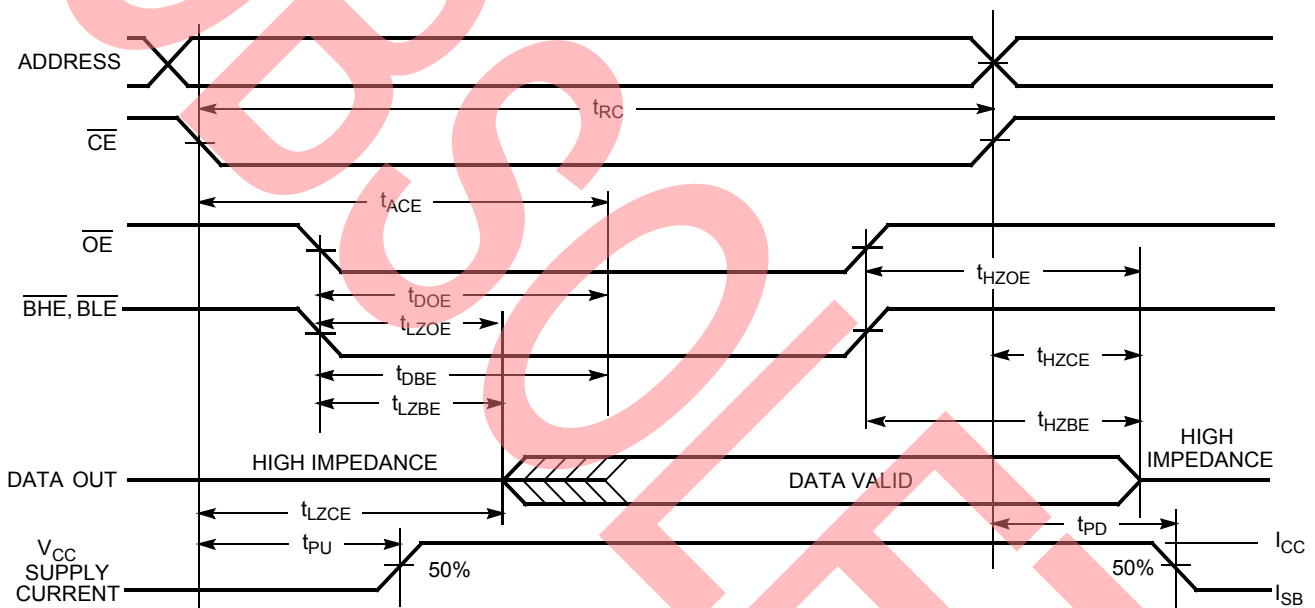


Figure 7. Read Cycle No. 2 ( $\overline{OE}$  Controlled) [16, 17]



Notes

- 15. Device is continuously selected.  $\overline{OE}$ ,  $\overline{CE}$ ,  $\overline{BHE}$ , and  $\overline{BLE}$  =  $V_{IL}$ .
- 16.  $\overline{WE}$  is HIGH for read cycle.
- 17. Address valid prior to or coincident with  $\overline{CE}$  transition LOW.

Switching Waveforms (continued)

Figure 8. Write Cycle No. 1 ( $\overline{\text{CE}}$  Controlled) [18, 19]

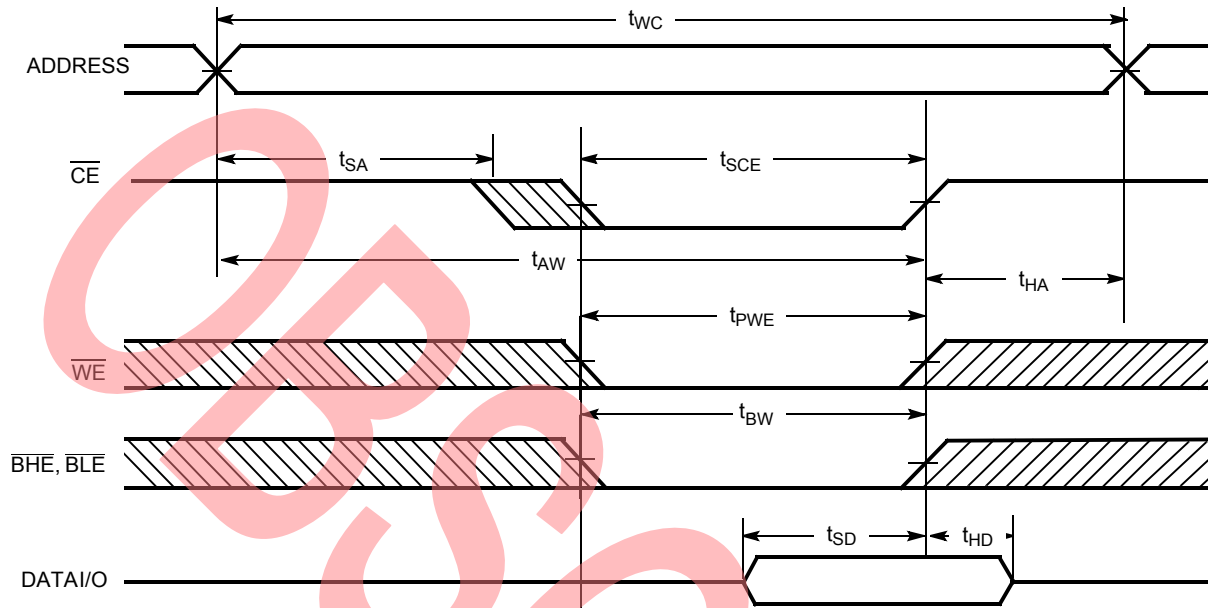
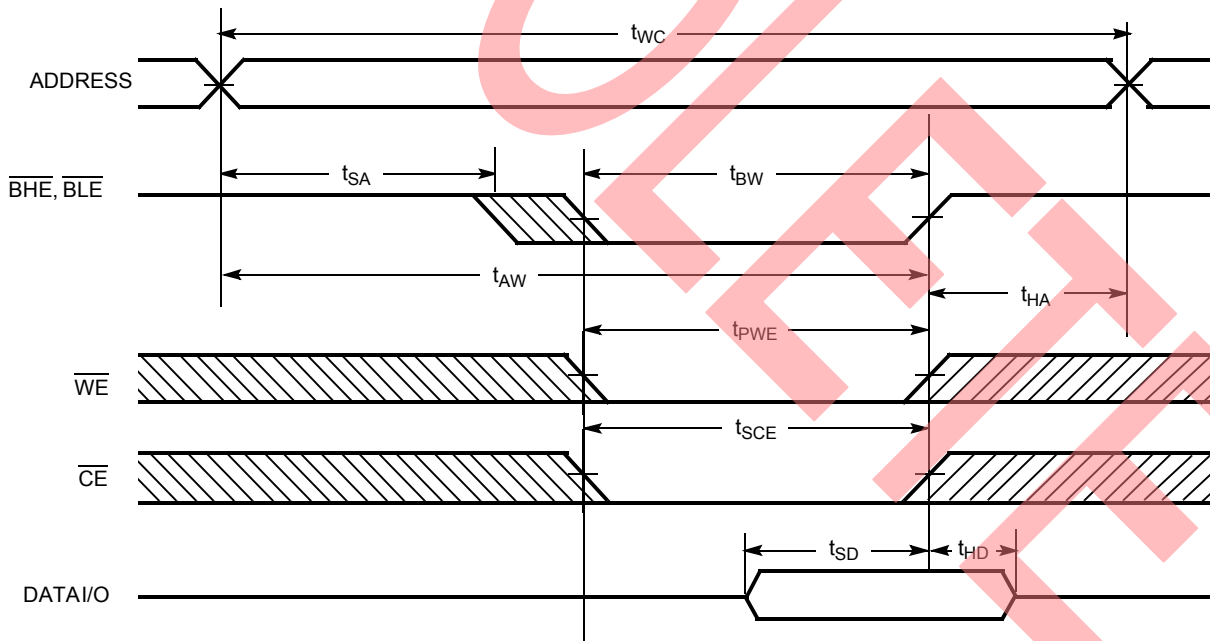


Figure 9. Write Cycle No. 2 ( $\overline{\text{BLE}}$  or  $\overline{\text{BHE}}$  Controlled)



Notes

- 18. Data I/O is high impedance if  $\overline{\text{OE}}$  or  $\overline{\text{BHE}}$  and  $\overline{\text{BLE}} = V_{\text{IH}}$ .
- 19. If  $\overline{\text{CE}}$  goes HIGH simultaneously with  $\overline{\text{WE}}$  going HIGH, the output remains in a high impedance state.

Switching Waveforms (continued)

Figure 10. Write Cycle No. 3 ( $\overline{WE}$  Controlled,  $\overline{OE}$  HIGH During Write) [20, 21]

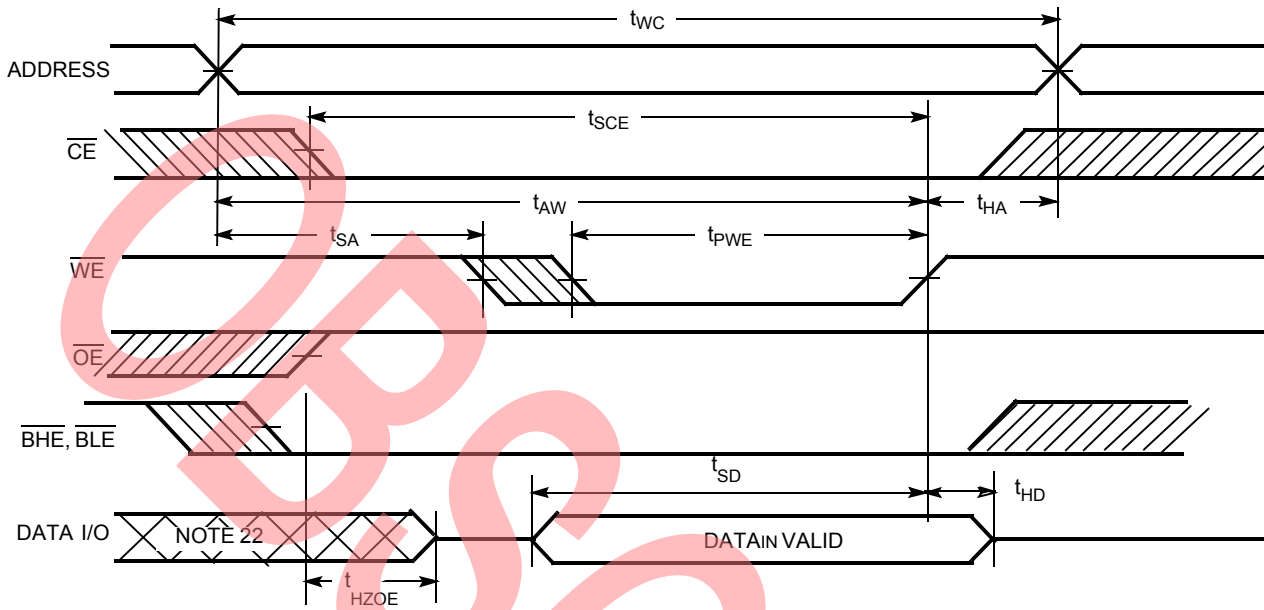
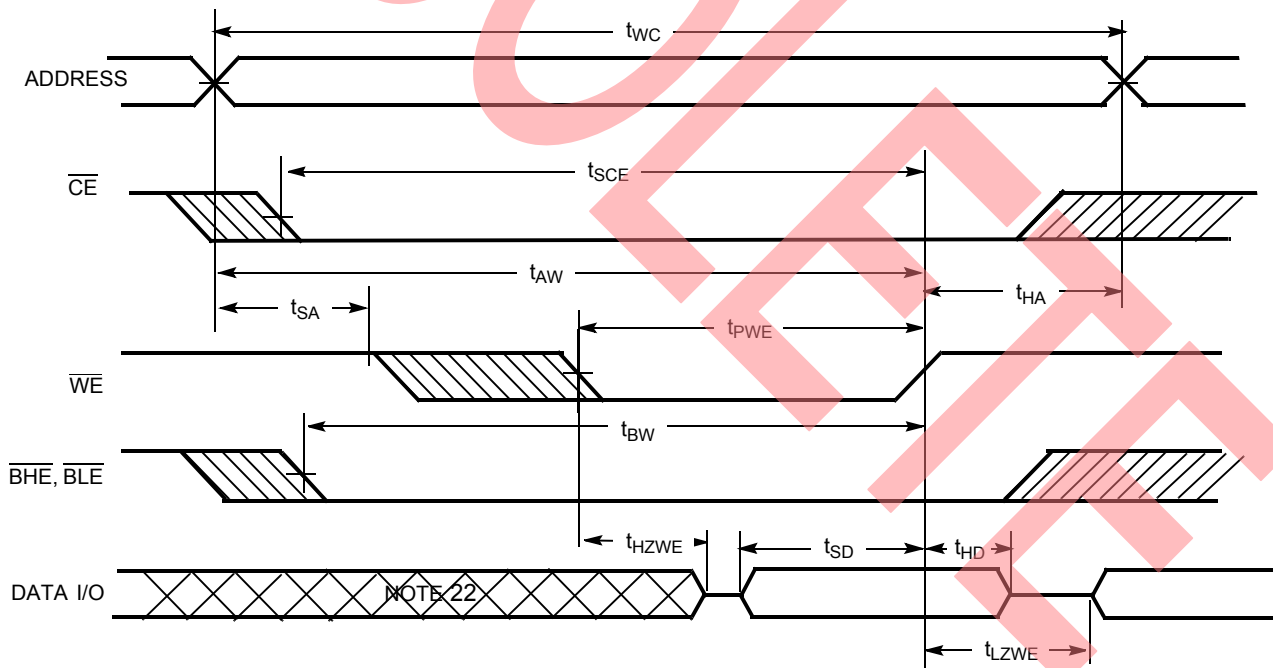


Figure 11. Write Cycle No. 4 ( $\overline{WE}$  Controlled,  $\overline{OE}$  LOW)



Notes

- 20. Data I/O is high impedance if  $\overline{OE}$  or  $\overline{BHE}$  and  $\overline{BLE} = V_{IH}$ .
- 21. If  $\overline{CE}$  goes HIGH simultaneously with  $\overline{WE}$  going HIGH, the output remains in a high impedance state.
- 22. During this period the I/Os are in the output state and input signals should not be applied.

**Truth Table**

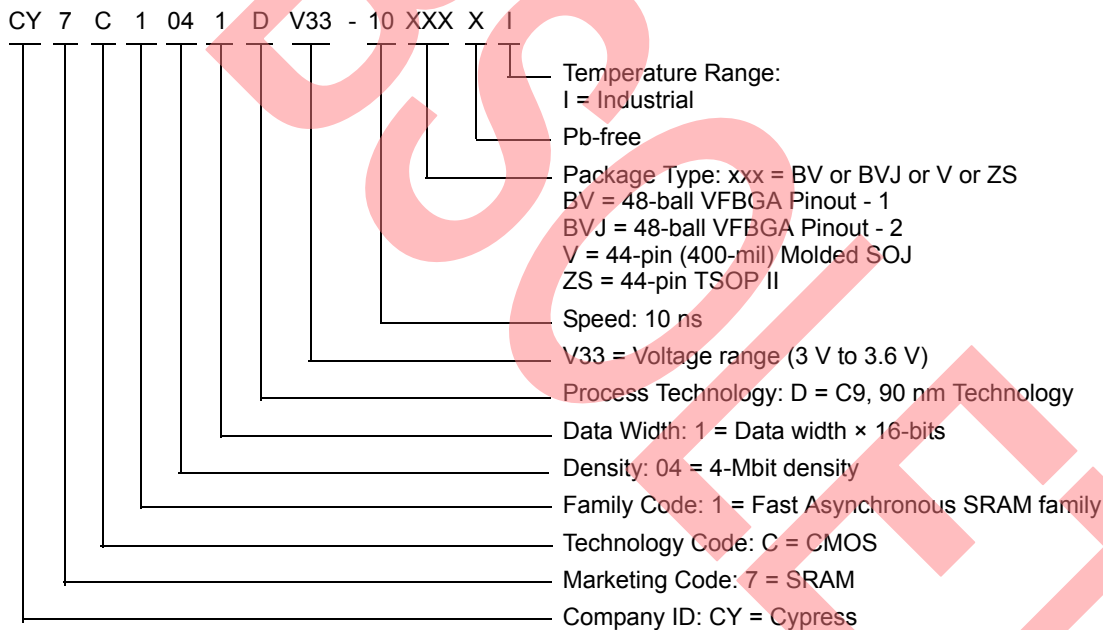
| $\overline{CE}$ | $\overline{OE}$ | $\overline{WE}$ | $\overline{BLE}$ | $\overline{BHE}$ | I/O <sub>0</sub> –I/O <sub>7</sub> | I/O <sub>8</sub> –I/O <sub>15</sub> | Mode                       | Power                      |
|-----------------|-----------------|-----------------|------------------|------------------|------------------------------------|-------------------------------------|----------------------------|----------------------------|
| H               | X               | X               | X                | X                | High Z                             | High Z                              | Power down                 | Standby (I <sub>SB</sub> ) |
| L               | L               | H               | L                | L                | Data out                           | Data out                            | Read all bits              | Active (I <sub>CC</sub> )  |
| L               | L               | H               | L                | H                | Data out                           | High Z                              | Read lower bits only       | Active (I <sub>CC</sub> )  |
| L               | L               | H               | H                | L                | High Z                             | Data out                            | Read upper bits only       | Active (I <sub>CC</sub> )  |
| L               | X               | L               | L                | L                | Data in                            | Data in                             | Write all bits             | Active (I <sub>CC</sub> )  |
| L               | X               | L               | L                | H                | Data in                            | High Z                              | Write lower bits only      | Active (I <sub>CC</sub> )  |
| L               | X               | L               | H                | L                | High Z                             | Data in                             | Write upper bits only      | Active (I <sub>CC</sub> )  |
| L               | H               | H               | X                | X                | High Z                             | High Z                              | Selected, outputs disabled | Active (I <sub>CC</sub> )  |
| L               | X               | X               | H                | H                | High Z                             | High Z                              | Selected, outputs disabled | Active (I <sub>CC</sub> )  |

**Ordering Information**

| Speed (ns) | Ordering Code        | Package Diagram | Package Type                                       | Operating Range |
|------------|----------------------|-----------------|--|-----------------|
| 10         | CY7C1041DV33-10BVI   | 51-85150        | 48-ball VFBGA Pinout - 1 <sup>[23]</sup>           | Industrial      |
|            | CY7C1041DV33-10BVXI  |                 | 48-ball VFBGA (Pb-free) Pinout - 1 <sup>[23]</sup> |                 |
|            | CY7C1041DV33-10BVJXI |                 | 48-ball VFBGA (Pb-free) Pinout - 2 <sup>[23]</sup> |                 |
|            | CY7C1041DV33-10VXI   | 51-85082        | 44-pin (400-mil) Molded SOJ (Pb-free)              |                 |
|            | CY7C1041DV33-10ZSXI  | 51-85087        | 44-pin TSOP II (Pb-free)                           |                 |

Contact your local Cypress sales representative for availability of these parts.

**Ordering Code Definitions**

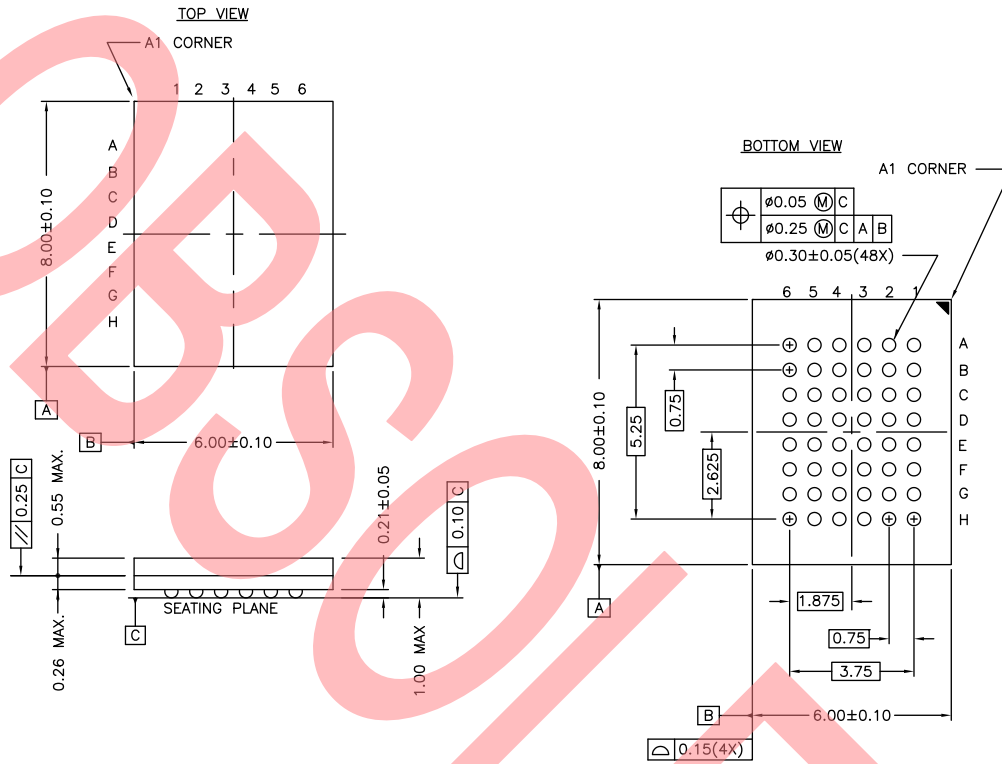


**Note**

23. Pinout 1 is compliant with CY7C1041CV33 and pinout 2 is JEDEC compliant. The difference between the two is that the higher and lower byte I/Os (I/O<sub>[7:0]</sub> and I/O<sub>[15:8]</sub> balls) are swapped.

Package Diagrams

Figure 12. 48-ball VFBGA (6 × 8 × 1 mm) BV48/BZ48 Package Outline, 51-85150



NOTE:  
 PACKAGE WEIGHT: See Cypress Package Material Declaration Datasheet (PMDD) posted on the Cypress web.

51-85150 \*H

Package Diagrams (continued)

Figure 13. 44-pin Molded SOJ (400-mil) V44.4 Package Outline, 51-85082

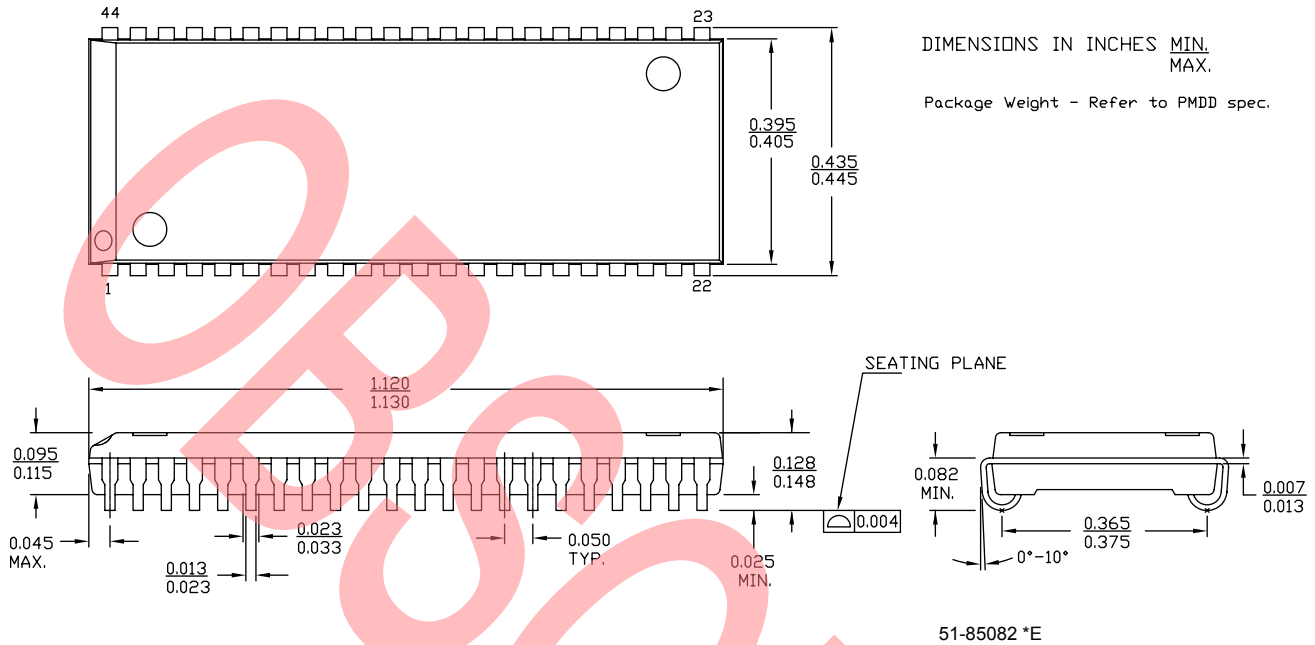
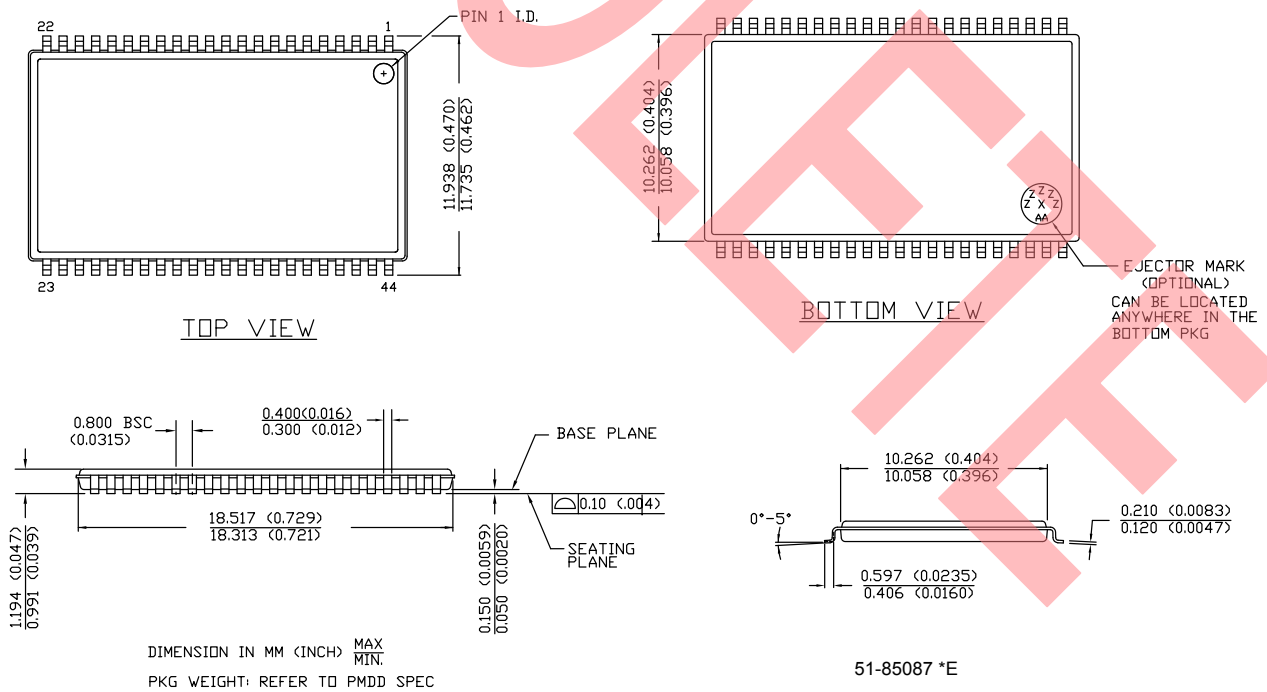


Figure 14. 44-pin TSOP Z44-II Package Outline, 51-85087



**Acronyms**

| Acronym         | Description                             |
|-----------------|---|
| $\overline{CE}$ | Chip Enable                             |
| CMOS            | Complementary Metal Oxide Semiconductor |
| FBGA            | Fine-Pitch Ball Grid Array              |
| I/O             | Input/Output                            |
| $\overline{OE}$ | Output Enable                           |
| SOJ             | Small Outline J-lead                    |
| SRAM            | Static Random Access Memory             |
| TSOP            | Thin Small Outline Package              |
| TTL             | Transistor-Transistor Logic             |
| VFBGA           | Very Fine-Pitch Ball Grid Array         |
| $\overline{WE}$ | Write Enable                            |

**Document Conventions**

**Units of Measure**

| Symbol | Unit of Measure |
|--------|-----------------|
| °C     | degree Celsius  |
| MHz    | megahertz       |
| μA     | microampere     |
| μs     | microsecond     |
| mA     | milliampere     |
| mm     | millimeter      |
| ns     | nanosecond      |
| pF     | picofarad       |
| V      | volt            |
| W      | watt            |



Document History Page

| Document Title: CY7C1041DV33, 4-Mbit (256K × 16) Static RAM |         |                 |                 |   |
|---|---------|-----------------|-----------------|---|
| Document Number: 38-05473                                   |         |                 |                 |   |
| Rev.  | ECN No. | Orig. of Change | Submission Date | Description of Change   |
| **  | 201560  | SWI             | See ECN         | Advance Data sheet for C9 IPP   |
| *A  | 233729  | RKF             | See ECN         | 1.AC, DC parameters are modified as per EROS(Spec # 01-2165)<br>2.Pb-free offering in the 'Ordering information'  |
| *B  | 351117  | PCI             | See ECN         | Changed from Advance to Preliminary<br>Removed 15 and 20 ns Speed bin<br>Corrected DC voltage (min) value in maximum ratings section from - 0.5 to - 0.3V<br>Redefined I <sub>CC</sub> values for Com'I and Ind'I temperature ranges<br>I <sub>CC</sub> (Com'I): Changed from 100, 80 and 67 mA to 90, 80 and 75 mA for 8, 10 and 12ns speed bins respectively<br>I <sub>CC</sub> (Ind'I): Changed from 80 and 67 mA to 90 and 85 mA for 10 and 12ns speed bins respectively<br>Added Static Discharge Voltage and latch-up current spec<br>Added V <sub>IH(max)</sub> spec in Note# 2<br>Changed Note# 4 on AC Test Loads<br>Changed reference voltage level for measurement of Hi-Z parameters from ±500 mV to ±200 mV<br>Added Data Retention Characteristics/Waveform and footnote # 11, 12<br>Added Write Cycle (WE Controlled, OE HIGH During Write) Timing Diagram<br>Changed Package Diagram name from 44-Pin TSOP II Z44 to 44-Pin TSOP II ZS44 and from 44-Pin (400-mil) Molded SOJ V34 to 44-Pin (400-mil) Molded SOJ V44<br>Changed part names from Z to ZS in the Ordering Information Table<br>Added 8 ns Product Information<br>Added Pin-Free Ordering Information<br>Shaded Ordering Information Table |
| *C  | 446328  | NXR             | See ECN         | Converted from Preliminary to Final<br>Removed -8 speed bin<br>Removed Commercial Operating Range product information<br>Included Automotive Operating Range product information<br>Updated Thermal Resistance table<br>Updated footnote #8 on High-Z parameter measurement<br>Updated the ordering information and replaced Package Name column with Package Diagram in the Ordering Information Table   |

Document History Page *(continued)*

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|---|---------|-----------------|-----------------|--|
| Document Number: 38-05473                                   |         |                 |                 |  |
| Rev.  | ECN No. | Orig. of Change | Submission Date | Description of Change  |
| *D  | 480177  | VKN             | See ECN         | Added -10BVI product ordering code in the Ordering Information table   |
| *E  | 2541850 | VKN / PYRS      | 07/22/08        | Added -10BVJXI part  |
| *F  | 2752971 | VKN             | 08/18/2009      | Added Automotive-A information<br>For 12 ns speed, changed I <sub>SB1</sub> spec from 25 mA to 15 mA<br>For 12 ns speed, changed t <sub>DOE</sub> and t <sub>DBE</sub> specs from 6 ns to 7 ns<br>Updated ordering information table   |
| *G  | 3034079 | PRAS            | 09/20/2010      | Added <a href="#">Ordering Code Definitions</a> .<br>Added <a href="#">Acronyms and Units of Measure</a> .<br>Minor edits  |
| *H  | 3082285 | HRP             | 11/09/2010      | Corrected typo in Note 20.   |
| *I  | 3149096 | AJU             | 01/24/2011      | No technical updates.  |
| *J  | 3182129 | HRP             | 03/02/2011      | No technical updates.  |
| *K  | 3271586 | PRAS            | 06/01/2011      | Updated <a href="#">Features</a> (Dislodged automotive part information to 001-69789).<br>Updated <a href="#">Functional Description</a> (Removed "For best practice recommendations, refer to the Cypress application note AN1064, SRAM System Guidelines.".)<br>Updated <a href="#">Selection Guide</a> (Dislodged automotive part information to 001-69789).<br>Updated <a href="#">Operating Range</a> (Dislodged automotive part information to 001-69789).<br>Updated <a href="#">DC Electrical Characteristics</a> (Dislodged automotive part information to 001-69789).<br>Updated <a href="#">AC Switching Characteristics</a> (Dislodged automotive part information to 001-69789).<br>Updated <a href="#">Data Retention Characteristics</a> (Dislodged automotive part information to 001-69789).<br>Updated <a href="#">Truth Table</a> .<br>Updated <a href="#">Ordering Information</a> (Dislodged automotive part information to 001-69789).<br>Updated to new template. |
| *L  | 3438781 | TAVA            | 11/15/2011      | Updated <a href="#">Package Diagrams</a> .   |
| *M  | 4170254 | MEMJ            | 10/22/2013      | Updated <a href="#">Package Diagrams</a> :<br>spec 51-85150 – Changed revision from *G to *H.<br>spec 51-85082 – Changed revision from *D to *E.<br>spec 51-85087 – Changed revision from *D to *E.<br>Updated to new template.  |
| *N  | 4578500 | MEMJ            | 12/16/2014      | Updated <a href="#">Functional Description</a> :<br>Added "For a complete list of related documentation, <a href="#">click here</a> ." at the end.<br>Updated <a href="#">AC Switching Characteristics</a> :<br>Updated Note 13.   |
| *O  | 5514203 | VINI            | 11/08/2016      | Obsolete document.<br>Completing Sunset Review.  |

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